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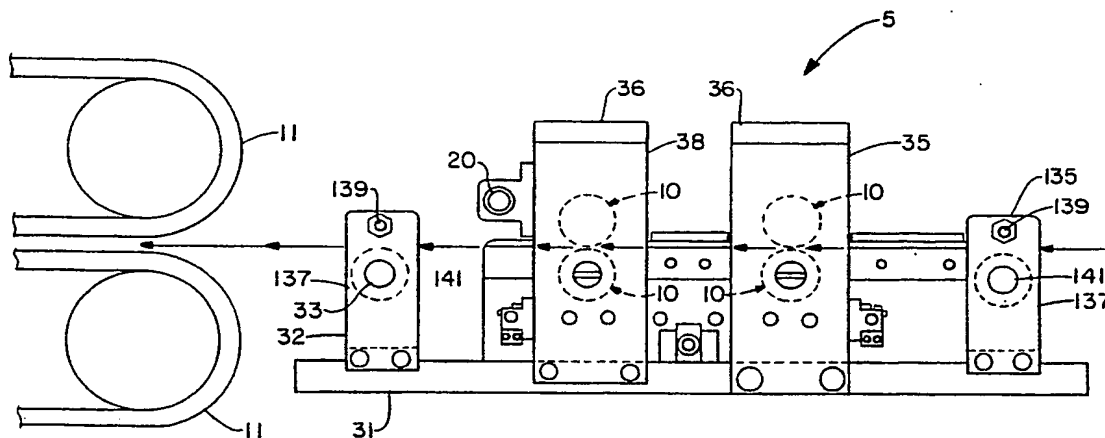
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(54) Title: MAGNETIZED MATERIAL HAVING ENHANCED MAGNETIC PULL STRENGTH AND A PROCESS AND APPARATUS FOR THE MULTIPOLAR MAGNETIZATION OF THE MATERIAL

**(57) Abstract**

A process and apparatus for permitting the magnetization of flexible hard magnetic materials in the form of sheets or strips, such as magnetic rubber, wherein opposing arrays (10) formed from alternating magnetic disks and flux conducting elements are used in sets of two with opposing polar moments such as to induce a magnetic flux in the gap between the disks. A material to be magnetized is passed between the array sets (35) and consequently imprinted with magnetic poles. The magnetization properties of the material is enhanced by passing the material through a second set (38) of arrays which are axially offset with respect to the first set of arrays. This enhances the residual induction of the sample and significantly improves the pull strength of the material.

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MAGNETIZED MATERIAL HAVING ENHANCED MAGNETIC PULL
STRENGTH AND A PROCESS AND APPARATUS FOR THE MULTIPOLAR
MAGNETIZATION OF THE MATERIAL

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FIELD OF INVENTION

The present invention relates to an apparatus and process for effecting a multipolar magnetization of a material which is preferably a flexible magnetizable material in the form of sheets or strips of the magnetic rubber type. The invention further relates to a magnetized material resulting from the process which has enhanced magnetic pull strength.

BACKGROUND

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It is known to imprint magnetic poles of alternating polarity on the surface of material by causing the material to travel in the immediate vicinity of the active portion of a magnetizing apparatus or in the air gap of such an apparatus producing an adequate magnetic field. The multipolar magnetization obtained on the material can be of the traversing or symmetrical type, which means that the two faces of the strip or of the sheet exert a magnetic attraction or pull strength of approximately the same value. On the other hand, it can be of a non-traversing or biased type and, in this case, one of the faces of the material exerts a biased or higher magnetic pull strength than the other face. The weaker or magnetically unbiased face may be advantageous for other uses and is able to receive, for example, some decoration, paint or an adhesive, or alternatively a sheet of mild magnetic material.

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In order to magnetize a material, it is necessary to apply an adequate magnetic field to it, the intensity of which depends on the magnetic intrinsic coercive force of the material (and the direction of which depends on the field lines to be imprinted in this material). Typically the intensity of the applied flux field should be at least two times the intrinsic coercive force (H_{ci}) of the material, and more particularly should

be three or more, the general rule being that a magnetic field three times the value of the material H_{ci} being necessary to achieve saturation magnetization.

5 In accordance with the prior art, magnetic fields are produced by direct, optionally pulsed electric currents by using, for example, electromagnets, coils (solenoids) or the discharge of capacitors.

10 These systems are essentially intended for single face magnetization. Nevertheless, they are expensive as they are complex, often fragile, subject to heating up and are high energy consumers and can be dangerous. They are limited in the number of poles per inch and in possible active surfaces due to problems of insulation of the conductors and the electromagnetic stresses applied to them. Moreover, the production rates are frequently limited to a strip speed of less than 3 m/min or about 10ft/min, and even much less in the case of double face multipolar magnetization (i.e., transverse type).

20 Alternatively, in the prior art, the magnetic field may be produced by permanent magnets, in which case, the following benefits are obtained:

25 very low energy consumption limited to the mechanical energy needed for extracting the magnetized material from the apparatus,

high reliability in operation,
high safety in use due to absence of high voltage, the elimination of internal stresses in the apparatus. However, the main disadvantages of systems using Alnico or ferrite type permanent magnets are:

30 the production of a relatively weak magnetic field resulting in difficulty of effecting magnetization of moderately coercive materials, and the difficulty in obtaining the multipolar magnetization of magnetic materials in sheet form as described above.

35 One method of multipolar magnetization is set forth in U.S. Patent No. 4,379,276 to Bouchara et al.

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which relates to a process and apparatus for permitting the magnetization of materials in the form of sheets or strips, such as magnetic rubber, wherein, a strip to be magnetized travels between stacks formed by a plurality of flat main magnets each of which is intermediate to flux conducting pole elements. The main magnets are magnetized through the thickness. The magnets and flux conducting pole elements are alternately stacked in axial alignment to form a cylindrical stacked array. The magnetic disks are aligned between the flux conducting pole elements and with the disks having opposing (i.e., mirror image) magnetizations with a flux conducting pole element located in between. Accordingly, a polar moment (North or South) is induced at the surface of the flux conducting pole element, and when two arrays are positioned with opposing opposite polar moments, the induced polar moment is enhanced. Preferably, these arrays have magnetic disks of equal thickness and flux conducting pole elements of equal thickness, and further the arrays are of the same size so that each induced pole has an opposing and opposite polar moment. It is believed that this configuration facilitates a flux circuit whereby the flux passes across a flux gap between the induced polar moments from the cylindrical surface of one array to the other in a first direction, through an adjacent magnetic disk in the direction of magnetization, across to the next array in a second direction opposite the first direction, and through a second magnetic disk to the first flux conducting element. When the pre-magnetized material is subjected to the flux circuits of the flux gap, the material is magnetized, i.e., one or more field lines are imprinted on the material. In the case of multipolar magnetization, the sample is polarized, i.e., is magnetized with alternating north and south poles.

SUMMARY OF THE INVENTION

The present invention relates to a device and

process for the magnetization of materials preferably in sheets or strips which overcomes all the above-mentioned disadvantages, in which the magnetic field is created by permanent magnets capable of magnetizing moderately coercive materials by imprinting very carefully controlled (i.e., poles having a controlled shape and location) multipolar magnetization and of permitting a very high speed of travel of material. The invention further relates to the magnetized product.

The device of the present invention utilizes more than one set of stacks or arrays of circular magnetic disks and circular flux conducting pole elements, i.e., permendurs. In each array, the magnetic disks are magnetized through the thickness and are aligned between permendurs. In each array, the magnetic disks are situated with opposing like poles, with a pole to pole distance (including one disk and one flux conducting pole element) as defining one pole space. This distance determines the characteristics of the magnetic imprint on the magnetized material and the pole spacing will preferably be selected such that the thickness of the sheet or strip material is less than one pole spacing. As the "gap" becomes greater than the pole spacing, the preferred "across the gap" flux circuit with the facing opposite pole from the second array now has competition with the opposite pole from the same array on its surface and much lower effective flux in the across the gap (thickness of material magnetized) direction is observed. The alignment of the magnetic poles of the magnetic disks induces a radial flux in the flux conducting pole element such that a polar moment or pole at the circumference is induced. More precisely, the pole is induced at both the outer and inner circumferences if a washer type flux conductor is used, although the flux is mostly induced at the outer circumference of the flux conducting washers. The flux is induced in a direction perpendicular to the direction of magnetization of the main magnetic disks.

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Accordingly, the array has alternating poles of flux at the circumference of the flux conducting elements. One array is aligned opposing a second array having opposite poles in alignment to form one set of arrays.

5 In order to magnetize a strip, the strip is made to travel linearly along a longitudinal axis in the immediate vicinity in between a first set of two opposing arrays, i.e., in the flux gap between the arrays, and preferably in at least partial contact with each array,
10 and more preferably in substantial contact with each array. By substantial contact it is meant that the lateral surface of the material touches both of the array set surfaces (i.e., having at least line contact with the top and the bottom array), or that it is in close enough
15 contact given the magnitude of the flux that an effective flux transfer is achieved. The strip travels with a lateral face approximately perpendicular to the planar faces of the disks within the longitudinal axis generally parallel to the planar faces of the disks. The alignment
20 along the direction of travel is carefully controlled so that the field lines are imprinted very precisely.

Further, in accordance with the present invention, the material is passed through two sets of arrays which are axially offset with regard to the
25 alignment of the induced circumferential poles. Optionally a third axially set of arrays which is offset as a function of lateral distance could be used to optimize the residual induction as well as to control the "shape" of the induced poles as determined by a flux mapping
30 technique.

Further, as an alternative embodiment of the present invention, the material passes from a set of magnetizing arrays to a biasing roller whereby the material is in contact with one of the arrays for a longer
35 period and as a result, the material has a stronger magnetic bias on one surface than the other, i.e., is a non-traversing magnetized strip. This embodiment can be

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practiced independently of the offset set of arrays or in addition to this aspect of the invention.

5 It is an object of the invention to provide an apparatus and a process for producing a more strongly and efficiently magnetized magnetic material than from existing processes, i.e., material which more optimally utilizes the inherent magnetic characteristics of the pre-magnetized sample. Applications which utilize the product of the present invention include weather stripping and
10 sealing, sign magnets, attractive and repulsive devices, motor applications and magnetic senders for sensing applications and the like. It is further an object of the invention to provide possible special shapes to the magnetized poles, i.e., other than the preferred nearly
15 "square wave" shape for optimized pull strength. For example some motor designs may require flux "spikes" which can be located using a controlled method of sensing application and the like. Another object of the invention is to provide an apparatus for the production of such
20 magnetized material at high speeds, i.e., including speeds up to and over 200 ft. per minute. It is a further object of the invention to provide an improved non-traversing magnetic material, as well as an apparatus and process for the production of the material.

25 An additional object of the invention is to provide a device which can be easily modified for the production of both a non-traversing magnetized material or a traversing magnetized material.

30 BRIEF DESCRIPTION OF DRAWINGS

The invention will be better understood by means of the drawings which merely show particular non-limiting embodiments, and wherein:

35 Fig. 1 is a side plan view of the apparatus in accordance with the invention set up for production of a traversing material;

Fig. 2 is a side plan view of the apparatus in

accordance with the invention set up for the production of a non-traversing material;

Fig. 3 is a front plan view showing a set of magnetic arrays;

5 Fig. 4 is a side plan view showing a set of magnetic arrays;

Fig. 5 is a top plan view showing a first and second laterally offset set of arrays and a biasing roller;

10 Fig. 6 is a side plan view showing a first and a second laterally offset set of arrays set of arrays and a biasing roller;

Fig. 7 is a top plan view showing a first, a second laterally offset set of arrays, and a third laterally offset set of arrays and a biasing roller;

15 Fig. 8 is a side plan view showing a first, a second laterally offset set of arrays, and a third laterally offset set of arrays and a biasing roller;

Fig. 9 is an end view of the height adjustment wedge in accordance with the invention;

20 Fig. 10 is a top plan view of the guide system for use with the apparatus in accordance with the invention;

Fig. 11 is a side plan view of the guide system of Figure 10;

25 Fig. 12 is an end plan view of the guide system of Figure 10;

Fig. 13 is a top plan view of the permanent magnet magnetizer in accordance with the invention;

30 Fig. 14 is the original flux map of B_r versus distance X across the lateral face of the sample for sample 3B with a steel backer;

Fig. 15 is a digitized version of the flux map of Fig. 14 of B_r versus distance X ;

35 Fig. 16 is a plot biased on Fig. 15 of B_r^2 versus distance X ;

Fig. 17 is a digitized flux map of B_r versus

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distance X across the lateral face of the sample for sample 3B without a steel backer;

Fig. 18 is a plot based on Fig. 17 of Br^2 versus distance X;

5 Fig. 19 is a series of flux maps plotting Br versus X for samples 1A, 1B and 1C for offset and bias for both the top and bottom of the samples.

10 DETAILED DESCRIPTION OF THE INVENTION

The invention relates generally to a magnetized material realizing more of its magnetic potential as noted by its hysteresis properties, and to a process and an apparatus for the production of this magnetized material.

15 The material of the present invention generally comprises a polymeric binder or matrix which contains magnetic particles. It is further often advantageous that the matrix is a elastomeric or thermoplastic material such as, for example, rubbery compositions which can be made in
20 appropriate configuration and which can accept appropriate loading of magnetic particles, specifically including chlorinated and chlorosulfonated polyethylene, polyisobutylene, nitrile rubbers, rubbers made from ethylene propylene and EPDM elastomers, ethylene vinyl
25 acetate, acrylate elastomers and copolymers or blends based on the foregoing. However, the application of the invention need not be limited to any specific binder material and the selection will depend upon the ultimate application of the resulting material. Likewise, the
30 invention is applicable to a broad range of magnetic fillers ranging from the low energy ferrite magnets, to the rare earth magnets, provided the intrinsic coercivity of the rare earth magnets is matched to the flux generated by the permanent magnetic disks. These fillers can be in
35 the form of particles or powder as is appropriate. Specific example of suitable magnetic particles include hard ferrite magnets such as barium ferrite, strontium

ferrite and lead ferrite, and low coercivity rare earth magnets. Typical loadings of these fillers are in the range of from about 50 percent to about 70 percent, more preferably from about 55 percent to about 65 percent by volume with the remaining percent being binder. Once again, the choice of the filler and the ratio of magnetic filler to matrix will depend upon the particular application for the product. Typically, the ferrite filler and loading will be selected so that the magnetic properties of the pre-magnetized ferrite material can be described as having a BhAX of from about 0.5 to about 1.6 MGOe; a Br of about 1,500 to about 2,600 G; a Hc of about 1,200 to about 2,300 Oe; a Hci of about 2,000 to about 4,000 Oe, taken through the thickness, i.e., perpendicular to the lateral face of the sample. The neodymium-boron iron ("NEO") magnets should be modified to a lower Hci of about 5,000 oersteds by compositional and process changes. The Delco melt spin process for NEO is optimum for providing particulate material to be used with the binder in the strips and sheets in accordance with the invention. Additives may be used as are known in the art including, for example, antioxidant, UV stabilizers, fungicides, antibacterial agents, and processing aids such as internal plasticizers and processing aids.

The non-magnetized material may be manufactured as is known in the art and according to the product application. In a preferred embodiment, the material is produced such as by calendering in sheet form or extrusion in strip form having a thickness ranging from about 0.010 inch to about 0.250 inch and over. Further, the material is generally planar and continuous on at least two parallel surfaces, although, it should be understood that a more complicated cross-section could be accommodated, such as, for example, a grooved or flanged configuration. In this case, magnetization would occur through an air gap at a grooved point, or perhaps more preferably by a mating configuration of the stacked magnetizing array.

The apparatus of the present invention acts to imprint magnetization on a non-magnetized material by generating a magnetic flux sufficient to cause technical saturation. The field generated through the flux conductor should be about three times the coercive field strength of the material to be magnetized. It is desirable to achieve technical saturation of the material in order to optimize the pull strength and other important magnetized qualities of the sample. Suitable magnetic materials for the magnetic disks used in the array include rare earth alloys such as rare earth cobalt or iron alloys, with specific examples including samarium cobalt magnets and neodymium-iron-boron rare earth magnets, such as those sold by EEC (Electron Energy Corp.) and TDK. Particular materials include such products having an energy product (B-H) max exceeding 25 MGOe, and preferably over 27 MGOe; a residual induction, B_r exceeding 10kG, a coercive force of more than 10 kOe and an intrinsic coercive force H_{ci} of more than 15kOe.

It is particularly advantageous in the present invention, that the material is polarized with a multitude of alternating poles as is illustrated in Figure 7, although it should be understood that the invention may apply to a sample which has only two opposing poles on a surface, or even to a sample which has a single pole with partial poles alongside on a surface.

A strip of magnetized material has multipolar magnetization, it if has a succession of alternating south poles and north poles separated by neutral zones on the two faces in the width direction. If this arrangement is periodic, the distance between two adjacent poles defines the pole space or polar step of magnetization. In this case, the field lines traverse the thickness of the strip and are approximately perpendicular to the faces of the magnetic disks, i.e., they are parallel to the longitudinal axis and edges of the sample.

The material which is used for the flux

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conducting pieces can be considered a magnetically mild material. This material is preferably soft iron or an iron-cobalt alloy, but it is also possible to use permalloy, iron-nickel alloys, silicon, or carbon steel, or soft ferrites, depending on the magnetic permeability required. A particularly preferred material is vanadium permendur, which is an alloy of 49 percent iron and 49 percent cobalt, the remaining 2 percent being vanadium. An example of such is sold by Allegheny Ludlum Steel Corporation.

As previously discussed and as is illustrated in Figure 1, a set 10 of magnetic arrays 12 is shown generally in Fig. 1. Each array comprises alternating series of uniform size magnetic disks 14 and generally uniform size flux conducting elements 15. The direction of magnetization of the magnetic disks 16 is axial with the poles being located at the circular faces of the disk. Two magnetic disks are generally situated on either side of the one flux conducting pole element 16 with the directions of magnetization N-S being opposed. The disks 14 and the pole elements 16 are generally circular, preferably having a similar outer diameter so that a smooth continuous cylindrical surface 17 is formed. The disks 14 and pole elements 16 further have a central hole so that the stacked array 12 is tightly journeled about the axle 18 and rotates without it. The axle 18 further carries a bushing 24 on either end for rotation relative to the apparatus. The arrays of disks 14 and elements 16 are held together mechanically, on the threaded arbor by a washer 20 and nut 27 which when tightened overcomes the magnetic repulsion of the magnetic disks. As the pole pieces serve to channel the magnetic flux produced by the opposing magnets towards the flux gap between the surfaces of the magnetizing medium, the north and south poles separated by neutral zones alternate. These polar moments are situated over the same width of the strip as the flux conductive elements and are situated at the point where

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the flux conducting contact pole pieces contact the surface of the magnetizing medium. There is also some flux loss to the inside diameter but this is usually a small percentage of the total flux generated.

5 Two opposing arrays are used together to form an array set (i.e., top and bottom arrays). The set contacts or at least effectively contacts either side of the material. The two arrays are placed in circumferential alignment so that the similar elements, i.e., magnetic
10 disks or flux conducting pole elements of each array face each other and the directions of magnetization N-S of two facing main magnets are opposed to each other. The proximity of the opposing stack, and the opposing poles induces a flux circuit as previously described through the
15 flux conducting pole elements. It is believed that the magnetic imprint is achieved when the material passes between the two stacks and completes the circuit. Thus, the material will be imprinted with a pole opposite from the surface contacting polar moment of the flux conducting
20 pole element. Each array ends with a distal flux conducting element 15 on either side. The distal flux conducting elements have a thickness which is one half the thickness of the intermediate flux conducting elements 13. This assures that the intensity of the magnetic flux in
25 these distal flux conducting elements will correspond with the intensity of the intermediate flux conducting elements.

Figure 14 shows the original contact flux map - B_r versus distance of sample 3B of Example 3 having a
30 steel "keeper." Figure 15 shows a recreation of the same flux map as a result of digitizing on a X-Y table. In Figure 16 the plot of Figure 15 was converted into a plot of B_r^2 versus lateral distance X across the surface of the sample. The total area under the B_r^2 versus distance curve
35 for the width of the sample is directly proportional to the contact pull strength measured when testing the breakaway force of that material from a cold rolled steel

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plunger. Figures 17-18 show the same digitized curves for sample 3B without a steel keeper. Figure 19 shows the effect of no offset, one offset set of arrays by itself, as well as both offset arrays and bias takeoff on magnetization of a low energy relatively isotropic ferrite sheet (samples 1A, 1B, 1C of example 1) - both topside and backside flux maps are shown for these samples.

The stacked flux conducting pole elements and the magnetic disks have the shape of circular discs having an internal bore which receives a non-ferromagnetic axis to facilitate a cylindrical external surface of revolution. Depending on the circumstances, the arrays can be driving rolls or they can freely rotate about their axes.

The flux curves shown in Figures 14 through 19 demonstrate residual induction (B_r) as a function of the lateral distance across the surface. This curve is related to the ultimate magnetic pull strength of the material. In fact, the pull strength is proportional to the square of B_r with an optimal wave profile (also referred to as pole peak) from one pole to the next being rectangular, i.e., having a straight slope from maximum to minimum. Figure 14 is the original flux map of B_r versus distance. Figure 16 is a graph of B_r^2 , residual induction, as a function of the lateral distance, x , across the surface of the sample for Figure 15, with Figure 15 illustrating a distalization of B_r as a function of the distance.

The distalized graph is a plot of the measured B_r using a traversing flux map probe Bell axial probe No. SAE 4-0608 being read through a Bell Model No. 620 gaussmeter. The probe is in substantial contact of the strip as it transverses the lateral face by substantial contact it means that there is less than a 0.005" of protective epoxy between the sensing loop and the sample. Since this traversing speed is slow, the scale of the X-axis is widely expanded.

It can be seen that the plots shown in Figure 19 illustrate the improvement in magnetic properties which results from the present invention. Two pole spaces are illustrated in the solid line as the linear progression across the sample from node to node for the top and bottom of the sample. The X scale is expanded for the sake of clarity. The intersection of the X and the y axis represents the center of the 1st magnetic disk which contacted the sample, while the 1st peak, max Br, represents the center of the flux conducting pole piece. The second intersection with the y-axis represents the center of the 2nd magnetic disk which contacted the sample and the inverted peak, min Br, represents the center of the next flux conducting pole piece.

The polar profile in Figure 19 illustrates the improvement of the invention. Specifically, the peak has been broadened, which would result in a significant increase in the area under the curve of Br^2 versus X. An inspection of the profile evidences a dual peak or polar shift in which the second peak is higher than the peak of the control sample. This second peak can be attributed to the second pass through a set of arrays, and the broadening is seen to be a result of the second set being axially offset with respect to the polar alignment of the first set. The axial distance that the second set should be offset is that distance which will cause the most significant increase in the integration of a plot of Br^2 versus X. Generally, through using either 1 or 2 offset passes in addition to the first set of arrays and using flux conductor to magnet thickness ratios of from 1 to 3.5 (i.e., from about 22.2 percent of total pole space covered by flux conductor) to about 1:1 (i.e., 50 percent of total pole space covered by flux conductor), it would be expected to have at least 66.6 percent pole coverage (22.2 percent x 3 passes) from either 1 offset (2 imprints) or 2 offset (3 imprints) passes. Some of the total pole coverages of all the examples shown are shown in the

summary of examples section. To this end, the offset is related to the width of the flux conducting element and to the width of the magnetic disks. It is usually optimal when the magnetic disk is from about 1 to about 3, and preferably about 1.5 to about 2.5 times the width or thickness of the flux conducting pole element. In this instance, when the sample is imprinted twice, it is preferable that the offset is equal to from about 0.5 to about 1.5 times the full width of a flux conducting element measured from the first edge of a full conducting element (of course, this assumes a uniform thickness for each flux conducting element and each magnetic disk, with the exception of the two end flux conducting elements which are 1/2 of the thickness in order to achieve a uniform flux concentration).

When the sample is imprinted three times, the first offset distance is equal to the width of the magnetic disk with a second axial offset distance being equal to about half of the width of the magnetic disk. More simply, the offset shift for 1 pass offset (2 imprints) is usually the amount of the width of the flux conductor. The offset pattern for best results of 2 pass offset (3 imprints) is first offset shift to apparent outside of complete pole, second offset between first and second passes (apparent middle of pole). The optimal actual amount of offset can be calculated empirically. Since there will be some shifting of the second peak toward the original peak indicating that the material has a magnetic memory.

In a second embodiment of the invention, the apparatus permits the production of biased (i.e., non-traversing) magnetization. This is accomplished by passing the material either from a sole set of arrays or alternately from the second, or offset array to a biasing roller. In this manner, the sample is held in contact with one of the two arrays for an additional period of time. The sample is pulled at an angle of from about 30°

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to about 90° and preferably from about 40° to about 80°, and most preferably from about 50° to about 70°, measured from the point at which the circumference and the shortest distance between the two arrays intersect to where the axis of the sample is tangential to the biasing roller. This angle is illustrated in Figure 6.

A flux map corresponding to the top (and to the bottom) of a biased non-traversing sample is presented in Figure 19 sample 1C procedure D. It can be seen that the peaks are more intense for one side than the other such that the pull strength (i.e., the integration of Br^2 versus distance) would be greater on one side, i.e., the biased side, than for the other. These values are further confirmed with actual contact pull tests against the sample being attached to a magnetic cold rolled steel plunger. Results are included in the examples.

Moreover, in accordance with the invention, the apparatus can be used for either traversing or non-traversing magnetization with a simple adjustment of the take-up position of the sample. No modification is necessary. This aspect of the invention can be practiced independently of the first aspect, i.e., without the use of an offsetting set of arrays.

The device shown in Figs. 3 and 4 comprises two stacks on their large faces of circular elements which are alternately permanent magnets made, for example, of a neodymium iron boron composition with a high coercive field, and induced flux and flux conducting pole elements having an induced flux and being made from, for example, of an iron cobalt alloy containing 49 percent of cobalt. The strip 3 travels in a plane approximately parallel to the circular interfaces of the members of the stack or array. The two stacks define an air gap 6. Each magnetic disk 16 and each flux conducting pole 16 of one of the stacks is situated opposite a magnet and a pole piece of the other similar stack, respectively. Moreover, in the case of two facing magnets on either side of the

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air gap 6, the directions of magnetization oppose each other. This, therefore, produces in the air gap at right angles to the pole pieces, a succession of field lines in alternating directions, represented by the arrows which will imprint an alternating succession of north and south poles separated by neutral zones over the width of the strip 3 traveling in the air gap 6.

The stacks are formed by alternating elements, main magnets 14 and pole pieces 16 in the form of circular discs which are movable about an axis and have a cylindrical lateral surface and rotate at such a speed that the strip is prevented from sliding relative to the magnetizing medium. Further the strip is held in alignment by a interference type guide which abuts one lateral edge of the strip and which biases the strip into contact with the opposing lateral guide. These guides are made from a low-friction material to avoid wear of the guide during use.

The offset array unit, i.e., the permanent magnet magnetizer fits into a slot in a base plate 1 and once the assembly has been positioned with the offset micrometer, it can be locked in place from under the base plate.

The device in accordance with the invention is shown in Figures 1-13. Fig. 1 is a side schematic illustrating a non-biased or non-traversing sample in which the sample exits a second set of arrays, i.e., the offset array station 142 in substantially the same plane in which it enters. This is also true for the first set of arrays, i.e., the first array station 143. The first and second set are aligned so that the flux gap between the arrays are parallel and contact the plane of the top and bottom surfaces of the sample.

The device generally comprises a base plate 31, having an outboard roll stand 32 which supports an outboard roll 33. The base plate 31 further carries a main stand 35, an offset stand 38, and an inboard roll

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stand 135. Each of the stands comprise a basic four bar linkage including the base plate 31, lateral side elements 137, and in the case of the main stand 35 and the offset stand 38 including top plates 36. The linkage is closed
5 on the inboard and outboard stands, 135, 32, respectively, by stabilizer bars 139. The inboard stand 135 further rotatably supports an inboard roll 141.

Each of the main stand 35 and offset stand 38 rotatably support a set or pair of opposing arrays 10
10 which have a bearing 24 that is journeled in a plastic bushing slot 141 to permit free rotation of the arrays 10 as the material is drawn through the device into a set of nip rollers 11. Of course it is evident that the bottom arrays will co-rotate as the material is drawn through.
15 The sample is held in a lateral position relative to the arrays 10 to assure a proper and precise imprint (i.e., induction) of the poles by a lateral guide assembly 28 shown in Figures 10-13.

Figure 2 illustrates a further embodiment in the
20 present invention for non-traversing magnetization. In accordance with this aspect of the invention, the sample is biased to one of the arrays of the invention, and preferably, the sample is biased to one of the arrays of the final offset station. In particular, this is accom-
25 plished by passing the sample from the second array station to a biasing roller 20 which is located at an angle degree of from about 30° to about 90° , with a preferred angle being from about 40° to about 80° , and with a most preferred angle being from about 50° to about 70° .
30 This angle is measured as the intersection of a line following the first path of travel along the longitudinal axis and a second line from the point on the circumference of the top offset making a chord with the circumference and passing tangentially to the bias roller 20. In order
35 that the sample passes linearly from the bias roller 20 to the nip rollers 11, the entire permanent magnetization assembly 5 is lowered.

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GUIDE SYSTEM

The guide system 144 shown in Figures 11-13 consists of a main body assembly 118 which has special pads on the bottom to allow for easy positioning. This assembly is held in a yoke 119 that is positioned by a micrometer slide block 50. On top of body assembly 18 is a plastic guide block 121 (bed) which has been designed to fit around the lower roll in an array set up. A material, Ertalon, was selected because it is non-magnetic, and it can be precision machined, and it will not wear away easily. In order to accommodate various standard widths of strip, a fixed side guide 123 is used. This guide is attached on top of 121 and to the left. A suitable material for these guide plates is AMPCO 18 bronze with a carbide edge insert. A different set of guide plates is required for each width of material. Along with the fixed edge guide is a top guide 124 loaded in a lateral direction by a spring loader 125. The top guide 124 consists of an Ertalon block with a carbide insert on one edge. The assembly is fixed to the guide bed 114 and defines a channel which provides the means for precision alignment of the material in relation to the pole pieces in the arrays. It is evident that this type of guide system is an interference type of guide system.

Once the main guide has been positioned in relation to the edge of the material and the desired pole position, it can be secured with a split clamp on the four corners of the main guide block. Since the guide block is one piece, it assures very precise, and repeatable positioning. Both precision and repeatability are necessary to assure proper positioning of field lines in the sample and to achieve an optimal peak shape (i.e., pole wave of a flux map).

Along with the main guide system, there is also an external preguide 138. This comprises a double set of tapered AMPCO bronze guide wheels which are positioned on a rotating shaft 139, then locked down with a split

- 20 -

collar. One of the bronze wheels has a tube extension 136 on it to allow the other (spring loaded wheel 132) to line up parallel and allow for width adjustments. Since this outboard guide is "free wheeling," another fixed roll is used to supply the necessary interference to make the guide work. The fixed roll is made of Teflon so the strip easily slips with a minimal amount of friction. Preguiding the material reduces the vibration which develops while running at high speeds, i.e., 200-240 fpm.

INTERFERENCE HEIGHT ADJUSTMENT

Figure 9 represents the wedge height adjustment means to accomplish a height adjustment. This adjustment is necessary for several reasons. First, the upper array in an array set is spring loaded in order to assure sample contact and to protect the assembly and must be positioned for a proper interference with respect to the thickness of the material (compression springs 211 bias a block which bears against the bearing 24). Also, the attractive force of a .125" pole spacing array set is approximately 126# in², and this force can deform the thinner <.060" material, causing the material to stretch in a linear direction, which not only changes precision imprint positioning, but the strip can also break at high speed operation.

The arrays 10 rotate in a non-magnetic stainless steel journal. An extension was added to one side on the upper corners of the array journals. These journals fit into a slotted stand 35, 38, with an extremely close tolerance fit, again to maintain alignment. Outbound of the side of the journal stand, a sliding wedge device 40 is used.

By design, there is a .018" gap built into the journal blocks between the arrays in an array set. This is to protect the arrays from banging together without any material in between. Allowing for that gap, the wedge supplies a precision method to set the height of one array

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relative to the other and maintain the proper interference to make intimate contact of the material with the rotating arrays.

5 The wedge consists of three pieces 213, 214. Often the apparatus in accordance with the invention must be disassembled, therefor, the aluminum base of the wedge has two ears which fit into a precision slot in the array set. Thus allows for automatic indexing of the wedge in relation to the journal extensions. The wedge itself is
10 slotted on the bottom, which matches a raised section in the base to insure alignment and true travel in the wedge direction. AMPCO 18 bronze is used for the wedge because it is a very hard material. One end of the wedge has a left hand thread. A stainless round knurled nut 217 is
15 placed on the threads and dropped between two upright sections 218 of the wedge base. By rotating the nut, the wedge is drive up or down the wedge base. By placing the nut in this yoke section of the base, a built-in locking mechanism is achieved, since the wedge will maintain its
20 position at high speeds when it is loaded.

PRODUCTION SPEED

The invention was designed to run in-line in the production environment (i.e, post extruder). Normal production line speeds are 120-150 fpm, but the invention
25 was designed to run at 240 fpm. After running almost 900,000 linear feet of various sizes of strip through the machine, no wear problems were found. Bearings were measured and found no measurable wear. The prototype runs showed that the invention is a high speed precision multi-
30 pole magnetizer.

MATERIALS

Basically, all materials used to fabricate the invention are non-magnetic. Suitable metals used include
35 non-magnetic stainless steel, aluminum, and bronze, even the bolts, screws and nuts are stainless steel. Parts of the guide system and bearing races are Ertalon, a PET type

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plastic. The carbide wear inserts in the guide system have the only non-magnetic material used. The carbide meets the abrasion resistance requirements and is only slightly attracted by magnetism.

5 Selection of the particular type of stainless steel was determined by the need for a tough non-magnetic material. Ertalon is an engineering plastic which lends itself to precision machining and provides gall free bearings for the array sets.

10 The results obtained using the process and the device according to the invention are illustrated by the following examples.

EXAMPLE 1

15 In accordance with Example 1 a sample of calendered flexible sheet having the dimensions, magnetic properties and particulate composition listing was magnetized. The binder was chlorosulfonated polyethylene and polyisobutylene, and the volume loading was about 60
20 percent. Three samples were run with the arrays set up as indicated and the magnetic properties are listed in Table I.

 This example demonstrates the effect of both the offset (1B) and the offset plus bias (1C) on the shape of
25 the induced poles (see flux map in Figure 19) on a calendered elastomer sheet containing very low energy product ferrite particles (i.e., .55MgOe). This sample utilizes a thin sheet (.020") magnetized with .080" pole spacing. This can be compared with the control sample 1A.
30 In particular, the effect of the invention is evident from the flux map, see Fig. 19. Furthermore, the influence of offset procedure on the shape of the poles and the influence of bias on the poles and the influence of bias on the flux density increase to the top side is dramatically shown in the flux maps and pull tests.
35 cally shown in the flux maps and pull tests.

 The polar shift and flux increase is significant and the resultant pull strengths shown in Table I verify

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the improvement over prior art, particularly for low energy (i.e., more isotropic) ferrite materials with no ferromagnetic (keeper) backer when measuring pull strength.

5

TABLE I

PART MAGNETIZED

Sample	Extruded strip or Sheet	Dimensions		Magnetized Thickness, In.	Magnetic Properties Through Thickness				
		Width, In.	Thickness, In.		Br, g	Hc, Oe	Hei, Oe	BHmax, Mgoe	
1A	Calendered Sheet	1.000	.020		1500	1270	2180	0.55	
1B	Calendered Sheet	1.000	.020		1500	1270	2180	0.55	
1C	Calendered Sheet	1.000	.020		1500	1270	2180	0.55	

TABLE I

MAGNETIZING PROCEDURE
1.250" OD X 0.500" ID ARRAYS

Sample	Magnet Type	Magnet Thickness, In.	Flux Conductor Type	Flux Conductor Thickness, In.	Total Pole Spacing, In.	Array Set Up	Magnetized Pull Strengths-Contact w/ steel Keeper psf	Top Bottom psf
1A	ECC NEO 33	.045	Vanadium Permenaur	.035	.080	A		Top 21.01 Bottom 19.85
1B	ECC NEO 33	.045	Vanadium Permenaur	.035	.080	C	N/R	Top 26.81 Bottom 24.80
1C	ECC NEO 33	.045	Vanadium Permenaur	.035	.080	D	N/R	Top 36.10 Bottom 19.60

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EXAMPLE 2

This example was run using conditions indicated in Table II. This is an example of magnetizing an .090" thick x .500" (wide) extruded strip at .925 energy product (Br=2000g) and .250" pole spacing using all the procedures set forth in the array description except E. An object of the invention was to achieve equal strength on both sides with a steel backer plate (also termed a "keeper" - i.e., a plate which backs the flexible magnet). Procedure 2C was selected because of the equal strength 2-side requirement. Note that biased first set of arrays 2B had similar pull results with a steel keeper. Without the keeper, the biased and offset condition (2D) was considerably better in pull strength than the prior art control (2A). Both bias alone (2B) and offset alone (2C) show improvements, bias showing the better of the two for this pole spacing, material thickness and magnetic properties of the material. Sample 2E was magnetized the same as sample 2C with an improvement in pull strength - with steel keeper of

$\frac{265.3}{221.5} = 1.198$ being roughly equivalent to the ratio of

$Br^2 \frac{21702}{2000^2} = 1.177$ or ratio of energy product

$\frac{1.10}{.925} = 1.189.$

KEY TO ARRAY SET UP

- A. Pass through one array set only (See Figure 5, position A-A).
- B. Pass through one array set and bias to first array set towards top array.
- C. Pass through one array set and pass through second array set offset the width of one flux conducting element measured from the first edge of the first full flux conducting element of the first array set (see Figure 5, Position B-B').

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- D. Pass through one array set and a second array set offset as described in C. above and bias to second array set towards top array (see Fig. 5 position C-C).
- 5 E. Pass through one array set, pass through second array, array set offset 0.090 inch from the first edge of the first full flux conducting element, pass through a third array set offset 0.045 inch from the first edge of the first full flux conducting element
- 10 and bias to third array set towards top array (see Fig. 7).

TABLE II

PART MAGNETIZED

Sample	Extruded Strip or Sheet	Dimensions Magnetized		Magnetic Properties Through Thickness				
		Width, In.	Thickness, In.	Br, G	Hc, Oe	Hei, Oe	BHmax, Mgoe	
2A	Extruded Strip	.505	.089	2000	1745	2295	.925	
2B	Extruded Strip	.502	.090	2000	1745	2295	.925	
2C	Extruded Strip	.506	.089	2000	1745	2295	.925	
2D	Extruded Strip	.506	.090	2000	1745	2295	.925	
2E	Extruded Strip	.506	.090	2170	1950	2820	1.10	

TABLE II

MAGNETIZING PROCEDURE
1.250" OD X 0.500" ID ARRAYS

Sample	Magnet Type	Magnet Thickness, In.	Flux Conductor Type	Flux Conductor Thickness, In.	Total Pole Spacing, In.	Array Set Up	Magnetized Pull Strengths-	
							w/steel Keeper psf	w/o keeper psf
2A	ECC NEO27	.145	Vanadium Permendur	.105	.250	A	190.5	85.4
2B	ECC NEO27	.145	Vanadium Permendur	.105	.250	B	221.1	109.9
2C	ECC NEO27	.145	Vanadium Permendur	.105	.250	C	221.5	98.9
2D	ECC NEO27	.145	Vanadium Permendur	.105	.250	D	217.5	115.0
2E	ECC NEO27	.145	Vanadium Permendur	.105	.250	C	265.3	N/R

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EXAMPLE 3

Table III shows a study on magnetizing .061" thick x .500 wide .76 MgOe extruded strip where .040/0.060 = 0.100" pole space ("ps"), 0.035/0.090 or 0.050/0.075 = 0.125" pole space, three different pole setups were selected, and two magnetizing procedures D & E. An object was to achieve 0.125" pole spacing and stronger pull strength to one surface with no steel keeper used. Bias was used on all setups. Sample 3A shows that respectable contact pull strength can be obtained with a narrower pole spacing 0.100" vs 0.125" (note that 0.100" is still much larger than the strip thickness of 0.060").

The procedure favored by and used in the production apparatus as .125" ps is noted as Sample 3C. This has somewhat lower pull strength than that achieved with Sample 3B, which requires an extra array set. On the other hand, the steel keeper backed pull strength is better with the magnetizing condition of Sample 3C. Conditions for Sample 3C were used for about 400,000-500,000 linear feet of production with precise pole position location.

Sample 3B illustrates the three array sets with the bias array setup (procedure E). This is shown in Figure 7.

1) The original flux map directly off the chart of Br versus distance across sample is shown in Figure 14 for the sample 3B with a steel backer. The digitized versions of Figure 14 are shown as Figure 15 as recorded on X-Y digitizer. Figure 16 uses the digitizer plotting points of Figure 15 to plot the graph of Br^2 versus distance across sample. For this sample, the area under the curve for the full width of the sample or summation Br^2 per 0.506" = 327, 364 gauss². The actual pull strength for this sample (Table III) = 165.2 PSF (pounds per square foot of sample).

2) The digitized versions of plots of Br

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versus distance across width and Br^2 versus distance across width for sample 3B with no steel keeper are shown in Figures 17 and 18 respectively. For this sample, the area under the curve for the full width of the sample or summation Br^2 per 0.507" = 267,346 gauss². The actual pull strength for this sample = 133.9 PSF, Therefore, ratio of summation Br^2

$$= \frac{327,364}{267,346} = 1.224$$

$$\text{ratio of actual pull strength} = \frac{165.2}{133.9} = 1.234$$

This illustrates the good correlation of summation Br^2 across the width with the pull strength of the samples.

The original flux map shown in Figure 14 shows the pole shape when three imprints of pole arrays are used (procedure E) with the final imprint at the middle of the pole. This flux map shows the flux peak at the center as contrasted with the flux peak to one side with the two imprint offset procedures (procedure C and D) and shown in Figure 19 - samples 1B, 1C. This clearly indicates that the procedures can controllably offset the flux intensity shape within a pole.

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TABLE III

PART MAGNETIZED

Sample	Extruded Strip or Sheet	Dimensions Width, In.	Magnetized Thickness, In.	Magnetic Properties Through Thickness			
				Br, g	Hc, Oe	Hei, Oe	BHmax, Mgoe
3A	Extruded Strip	.501	.061	1830	1550	2430	0.76
3B	Extruded Strip	.506	.062	1830	1550	2430	0.76
3C	Extruded Strip	.505	.061	1830	1550	2430	0.76

TABLE III

MAGNETIZING PROCEDURE
1.250" OD X 0.500" ID ARRAYS

Sample	Magnet Type	Magnet Thickness, In.	Flux Conductor Type	Flux Conductor Thickness, In.	Total Pole Spacing, In.	Array Set Up	Magnetized Pull Strengths-	
							Contact w/steel Keeper psf	w/o keeper psf
3A	ECC NEO27	.060	Vanadium Permendur	.040	.100	D	N/R	128.7
3B	ECC NEO27	.090	Vanadium Permendur	.035	.125	E	165.2	133.9
3C	ECC NEO27	.075	Vanadium Permendur	.050	.125	D	175.1	124.5

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EXAMPLE 4

Example 4 shows the effect of all one and two array set procedures (4A, 4B, 4C, 4D) on a relatively high energy (1.15 MgOe) .030" sheet. Again, this example illustrates both bias and offset improvements over the control (i.e., the prior art) without the stack keeper. It appears that both bias and offset have beneficial results compared to control (4A). See Table IV for conditions and results.

10

TABLE IV

PART MAGNETIZED

Sample	Extruded Strip or Sheet	Dimensions Magnetized		Magnetic Properties Through Thickness				
		Width, In.	Thickness, In.	Br, g	Hc, Oe	Hei, Oe	BHmax, Mgoe	
4A	Sheet	.500	.030	2200	1970	2550	1.15	
4B	Sheet	.500	.030	2200	1970	2550	1.15	
4C	Sheet	.500	.030	2200	1970	2550	1.15	
4D	Sheet	.500	.030	2200	1970	2550	1.15	

TABLE IV

MAGNETIZING PROCEDURE
1.250" OD X 0.500" ID ARRAYS

Sample	Magnet Type	Magnet Thickness, In.	Flux		Total Pole Spacing, In.	Array Set Up	Magnetized Pull Strengths-	
			Conductor Type	Conductor Thickness, In.			Contact w/steel Keeper psf	w/o keeper psf
4A	ECC NEO33	.045	Vanadium Permendur	.045	.090	A	N/R	101.3
4B	ECC NEO33	.045	Vanadium Permendur	.045	.090	B	N/R	131.7
4C	ECC NEO33	.045	Vanadium Permendur	.045	.090	C	217.4	114.6
4D	ECC NEO33	.045	Vanadium Permendur	.045	.090	D	220.2	136.4

1 36 1

EXAMPLE 5

As shown in Table V, this example illustrates that a wide variety of pole spacings (1/4", 1/3", 1/2") at various magnetic thicknesses and energies can be useful with this invention. These were magnetized equal strength on both sides (procedure C) and included the 0.127" thick strip with the best magnetic properties (1.55 MgOe, 2530g Br, sample 5A). The maximum gauss reading between permendurs of an array set 0.127" apart (same as 5A thickness) was measured as 9300 gauss using a Bell Transverse probe HTL-0608. This is over 3 times the Hci of the 5A sample, which was 2890 Oe oersteds.

With such a variety of pole spacings illustrated by these examples and other samples in prior examples utilizing the procedure of this invention, it would be useful to know what "reach" of the magnetized samples had in relation to its contact pull strength as the air gap was increased.

By designing a pull tester which requires a cold rolled steel plunger, connected to a load cell, to retract from a stationary sample at a given linear retraction rate, a pounds per square foot pull strength can be obtained not only for contact or breakaway pull, but also for pull strength at various air gaps from the magnet. Utilizing this test, we were able to determine the air gap at which the sample retains 50 percent of its contact pull strength and the air gap when it retains 25 percent.

This indicates a very strong correlation between pole spacing and retention of contact pull strength at various air gaps.

The 5C sample with a steel keeper had .520" pole spacing, a contact pull strength (CPS) of 335 PSF and retained 50 percent of CPS at .048" air gap and 25 percent of CPS at .104" air gap. The 5B sample with a steel keeper had .334" pole spacing, a contact pull strength (CPS) of 294.1 PSF and retained 50 percent of CPS at .028" air gap and 25 percent of CPS at .055" air gap. The 5A

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sample with a steel keeper had .250" pole spacing, a contact pull strength (CPS) of 356.0 PSF and retained 50 percent of CPS at .026" air gap and 25 percent of CPS at .051" air gap. The 3C sample without a keeper had .125" pole spacing, a contact pull strength (CPS) of 124.5 PSF and retained 50 percent of CPS at .014" air gap and 25 percent of CPS at .025" air gap. The 3A sample without a steel keeper had .100" pole spacing, a contact pull strength (CPS) of 128.7 PSF and retained 50 percent of CPS at .012" air gap and 25 percent of CPS at .023" air gap. The 1A (Top) sample without a steel keeper had a contact pull strength (CPS) of 36.1 PSF and retained 50 percent of CPS at .009" air gap and 25 percent of CPS at .017" air gap.

15

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SUMMARY

In summary, the foregoing examples illustrate:

1) flexible magnet thickness from .020, (Examples 1A, 1B, 1C) to 0.248" (Example 5D).

5 2) flexible magnet energy products from 0.55 MgOe (Examples 1A, 1B, 1C) to 1.55 (Example 5A) MgOe.

3) flexible magnet Br ranging from 1500 g (Example 1A) to 2530 g (Example 5A).

10 4) flexible magnet Hc's from 1270 Oe (Example 1A) to 3930 Oe (Example 5C).

5) five magnetizing procedures as given in A, B, C, D, E including the three array set (Example 3B).

6) different pole spacings from .080 (Example 1A) to .520" (Examples 5C, 5D)

15 7) flux map pole shapes - sample 3B versus Examples 1B, 1C - that are illustrated from original graphs - Figures 14, 19.

In addition, Table VI illustrates the pole spacing makeup in terms of thickness of magnet (either EEC NEO27 or EEC NEO33) and thickness of flux conductor (vanadium permendur), expresses the flux conductor (FC) thickness as a percent of total pole thickness (pole spacing), then, with the number of imprints involved including offset passes, shows the total pole "coverage" of the FC passes in combination, including offset passes.

20

25

TABLE VI

POLE COVERAGE FOR 1.250" OD X .500" ID ARRAY SETS

FC (Vanadium Permendur)	M (Neo) Width	Pole Spacing (FC+M) In.	100FC/ FC+M % FC	Total No. of Passes	Total Coverage FC %	Series or Sample Number
In.	In.	In.	% FC			
.035	.045 ¹	.080	43.75	2	87.50	1A, 5C
.045	.045 ¹	.090	50.00	2	100.00	4A, B, C, D
.040	.060 ²	.100	40.00	2	80.00	3A
.035	.090 ²	.125	28.00	3	84.00	3B
.050	.075 ²	.125	40.00	2	80.00	3C
.105	.145 ²	.250	42.00	2	84.00	2A-2E, 5A
.134	.200 ²	.334	40.00	2	80.00	5B
.220	.300 ²	.520	42.30	2	84.60	5C, 5D

¹ ECCNEO33, Br = 12,200q, Hc = 10,600 Oe, Hcl = >15,000 Oe, BHmax = 33.5MgOe

² ALL OTHERS - ECCNEO27 Br = 10,800g, Hc = 10,200 Oe, Hcl = >15,000 Oe, BHmax = 27.5 MgOe

TABLE V

PART MAGNETIZED

Sample	Extruded or Sheet	Dimensions Magnetized		Magnetic Properties Through Thickness				
		Width, In.	Thickness, In.	Br, g	Hc, Oe	Hei, Oe	BHmax, Mgoe	
5A	Extruded Strip	1.005	.127	2530	2280	2890	1.55	
5B	Extruded Strip	.992	.092	2360	2080	3610	1.32	
5C	Extruded Strip	.986	.236	2320	2100	3930	1.27	
5D	Extruded Strip	.972	.248	1750	1440	2380	0.67	

TABLE V

MAGNETIZING PROCEDURE
1.250" OD X 0.500" ID ARRAYS

Sample	Magnet Type	Magnet Thickness, In.	Flux Conductor Type	Flux Conductor Thickness, In.	Total Pole Spacing, In.	Array Set Up	Magnetized Pull Strengths-	
							Contact w/steel psf	w/o keeper Keeper psf
5A	ECC NEO27	.145	Vanadium Permendur	.105	.250	C	356.0	235.0
5B	ECC NEO27	.200	Vanadium Permendur	.134	.334	C	294.1	N/R
5C	ECC NEO27	.300	Vanadium Permendur	.220	.520	C	338.7	163.8
5D	ECC NEO27	.300	Vanadium Permendur	.220	.520	C	191.8	114.9

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While in accordance with the Patent Statutes, the best mode and preferred embodiment has been set forth, the scope of the invention is not limited thereto, but rather by the scope of the attached claims.

5

WHAT IS CLAIMED IS:

1. A composition comprising magnetized magnetic particles in a binder material wherein the magnetic pull strength of the composition has been enhanced, said pull strength being proportional to the integration of Br^2 (residual induction), versus the distance X which is a lateral width across the surface of the material.
2. A composition as set forth in claim 1, wherein said polarized magnetic particles in a binder material have more than at least one full magnetic pole on one surface, and the pull strength of at least one full pole has been enhanced by inducing a bimodal pole peak which is evidenced by an increased integration of Br^2 versus the distance X.
3. A composition as set forth in claim 2, wherein said enhancement in said pole is evidenced by a Br residual induction peak which is the plot of Br versus X, said residual induction peak having at least a primary peak and a shoulder.
4. A composition as set forth in claim 3, wherein said composition is a substantially planar material.
5. A composition as set forth in claim 4, wherein said material is in the form of a sheet or strip.
6. A composition as set forth in claim 5, wherein said binder comprises an elastomeric or thermoplastic binder.

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7. A composition as set forth in claim 6, wherein said magnetic particles comprise a hard ferrite or low coercivity rare earth magnet.

5 8. A composition as set forth in claim 7, wherein said magnetic particles comprise one or more materials selected from the group consisting of barium ferrite, strontium ferrite, lead ferrite, and neodymium boron-iron magnets.

10 9. A composition as set forth in claim 8, wherein said binder is one or more materials selected from the group consisting of chlorinated and chlorosulfonated polyethylene, polyisobutylene, nitrile
15 rubbers, rubbers made from ethylene propylene and ethylene propylene diene monomers, ethylene vinyl acetate, acrylate rubbers, and copolymers or blends of the same.

20 10. A composition as set forth in claim 9, wherein said magnetic particles comprise from about 50 to about 70 volume percent of said composition.

25 11. A composition as set forth in claim 10, wherein said magnetic particles comprise from about 55 to about 65 volume percent of said composition.

30 12. A composition as set forth in claim 11, wherein said sample has a Br of from about 0.5 to about 1.6 MGOe; a Br of from about 1,500 to about 2,600 g; a Hc of about 1,200 to about 2,300 Oe; and a Hci of about 2,000 to about 4,000 Oe taken through the thickness.

35 13. A composition having increased magnetic pull strength, said composition having a Br of from about 0.5 to about 1.6 MGOe; a Br of from about 1,500 to about 2,600 g; a Hc of about 1,200 to about 2,300 Oe;

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and a Hci of about 2,000 to about 4,000 Oe taken through the thickness,

5 said composition comprising an elastomeric or thermoplastic binder having a volume loading of from about 50 to 70 percent of hard ferrite magnets or low coercivity rare earth magnets, and said compound being in the form of a sheet or strip, and

10 said composition being magnetized such that it has an enhanced pull strength as evidenced by an increased integration of the plot of the Br^2 versus X for the width of the sample.

14. A composition as set forth in claim 13, wherein said plot includes a peak correlating to a pole and said peak includes a polar shift such that said pole has at least two Br max peaks.

15 15. A composition as set forth in claim 14, wherein said second peak is offset from said first peak a distance which corresponds to the width of said first peak.

20 16. A composition as set forth in claim 15, wherein said composition is multipolar.

25 17. A composition as set forth in claim 16, wherein the distance X between the first intersection of the X axis and the plot of Br versus X and the second intersection of the X axis and the plot of Br versus X is equal to one pole space, and said material has a thickness which is less than one pole space.

30 18. A composition as set forth in claim 13, wherein said material is non traversing.

35 19. A composition as set forth in claim 13, wherein the integration of Br^2 versus X for

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the total sample is greater as measured for one side of the sample compared to that as calculated for the other side.

5 20. A process for the magnetization of a coercive material having a longitudinal axis comprising the steps of:

 making a first magnetic imprint in said material by passing the material through a first flux gap, said flux gap being created in the vicinity of a flux circuit;

 making a second magnetic imprint in said material by passing the material through a second flux gap, each of said first and second flux gaps having at least one polar moment, and said at least one first polar moment being offset relative to said at least one second polar moment a distance X in a lateral direction across the material and perpendicular to the longitudinal axis of said material.

20 21. A process for magnetization as set forth in claim 20, wherein said first flux gap has a polar imprint which corresponds with a polar imprint from said second flux gap except that said second imprint is offset a distance.

 22. A process for magnetization as set forth in claim 21, wherein said first and second imprint each have at least one full pole and one partial pole across the lateral width of the material.

30 23. A process for magnetization as set forth in claim 22, wherein said first and said second flux gap have at least two full poles across the lateral width of the sample.

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24. A process for magnetization as set forth in claim 23, wherein said material is substantially planar and extending along the longitudinal axis, and has a top surface and a bottom surface and wherein said first imprint is made by at least partially contacting said top surface with a top array of alternating permanent magnetic disks and flux conducting pole elements and at least partially contacting said bottom surface with a bottom array of alternating permanent disks and flux conducting pole elements, said flux conducting pole elements having induced polar moments, and the polar moments of one array opposing the polar moments of the other array, and wherein said second imprint is made by at least partially contacting said top surface with a top array which is laterally offset from said first imprint top array and by at least partially contacting said bottom surface with a bottom array which is laterally offset from said first imprint top array and by at least partially contacting said bottom surface with a bottom array which is laterally offset from said first imprint bottom array.

25. A process for magnetization as set forth in claim 24, wherein the first imprint top and the bottom arrays form a first set of arrays, second imprint top and bottom arrays form a second set of arrays, and the thickness of the magnetic disks of said first set and said second set of arrays is uniform.

26. A process for magnetization as set forth in claim 25, wherein each array has a distal flux conducting pole moment on either side of each array and intermediate flux conducting elements interior to the distal flux conducting pole moments and the thickness of the intermediate flux conducting elements on each array is uniform.

- 49 -

27. A process for magnetization as set forth in claim 26, wherein the thickness of each of the distal flux conducting elements is one half the thickness of one of said intermediate flux conducting elements.

5

28. A process for magnetization as set forth in claim 27, wherein said distance X equals the thickness of one of said intermediate flux conducting disks.

10

29. A process for magnetization as set forth in claim 24, further comprising making a third magnetic imprint.

15

30. A process for magnetization as set forth in claim 28, wherein said material is a flexible sheet or strip.

20

31. A process for magnetization as set forth in claim 30, wherein the thickness of one of said magnetic disks is from about 1 to about 3.5 times the thickness of one of said intermediate flux conducting elements.

25

32. A process for magnetization as set forth in claim 31, wherein said material travels in a linear direction between said first flux gap and said second flux gap.

30

33. A process for magnetization as set forth in claim 32, wherein said material is biased to one of said arrays of said second set of arrays.

35

34. A process for magnetization as set forth in claim 33, wherein said biasing is accomplished by passing said material from said second flux gap to a biasing roller, a tangent passing from said biasing

- 50 -

roller to said one of said arrays of the second set of arrays forming an angle of from about 30° to about 90° with respect to the longitudinal axis of said material.

5

35. A process for the biased magnetization of a coercive material having a longitudinal axis comprising the steps of:

10 making a first magnetic imprint in said material by passing the material through a first flux gap, said flux gap being created in the vicinity of a flux circuit in the space between a first magnetic array and a second magnetic array, and said imprint being more strongly biased on one surface of the material by
15 biasing said sample towards said first or said second array.

20 36. A process for biased magnetization as set forth in claim 35, wherein said biasing is accomplished by passing said material from said flux gap to a biasing roller.

25 37. A process for biased magnetization as set forth in claim 36, wherein said material travels along a first line prior to passing thorough said flux gap, and along a second line after passing through said flux gap, said first and said second line defining an angle α , said angle α being from about 30° to about 90° .

30

38. A process for biased magnetization as set forth in claim 37, wherein said angle α is from about 40° to about 80° .

35

39. An apparatus for the magnetization of a material, said apparatus comprising a first set and a second set of arrays comprising a top magnetic array and

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5 a bottom magnetic array, said arrays each comprising at least two magnetic disks of equal thicknesses magnetized through the thickness and an intermediate flux conducting element between said two disks, said two disks being positioned with opposing like poles whereby a polar moment is induced at the circumferences of said flux conducting element and said top and said bottom magnetic array being aligned with opposite opposing polar moments, and said second magnetic array being axially offset from said first magnetic array.

15 40. An apparatus for magnetization as set forth in claim 39, said apparatus further comprising a biasing roller.

41. An apparatus for magnetization as set forth in claim 40, wherein said axial offset is equal to the thickness of said magnetic disk.

20 42. An apparatus for magnetization as set forth in claim 41, wherein each of said arrays has a series of intermediate flux conducting elements of a uniform thickness and has a distal flux conducting element on either side, each of said distal flux conducting elements having a thickness of about one half of the thickness of said intermediate flux conducting elements.

30 43. An apparatus for magnetization as set forth in claim 42, wherein said material is in the form of a strip and said material is longitudinally aligned in said apparatus by an interference guide system.

35 44. An apparatus for magnetization as set forth in claim 43, wherein said guide system is substantially comprised of a magnetically non-conducting material.

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45. An apparatus for magnetization as set forth in claim 39, wherein at least one array of each set of arrays is biased mounted to define a gap through which said material passes.

5

46. An apparatus for magnetization as set forth in claim 45, wherein wedge height adjustment means are used to adjust the distance of said gap.

10

47. An apparatus for magnetization as set forth in claim 39, wherein said material is fed to said apparatus from an extruder.

15

48. An apparatus for magnetization as set forth in claim 39, wherein the components excluding the magnetic disks are substantially comprised of magnetically non-conductive material.

20

49. An apparatus for magnetization as set forth in claim 39, said apparatus further comprises a third set of arrays, axially offset from said first set.

25

50. An apparatus for the magnetization of a material, said apparatus comprising at least a first set of arrays comprising a top magnetic array and a bottom magnetic array, said arrays each comprising at least two magnetic disks of equal thicknesses magnetized through the thickness and an intermediate flux conducting element between said two disks, said two disks being positioned with opposing like poles whereby a polar moment is induced at the circumferences of said flux conducting element and said top and said bottom magnetic array being aligned with opposite opposing polar moments, and biasing means whereby said material is biased to one of said arrays.

35

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51. An apparatus for magnetization as set forth in claim 50, wherein said biasing means is a biasing roller.

5 52. An apparatus for magnetization as set forth in claim 51, wherein said material travels along a first line prior to passing between said set of arrays, and along a second line after passing said set of arrays said first and said second line defining an
10 angle α , said angle α being from about 30 to about 90°.

 53. An apparatus for magnetization as set forth in claim 52, wherein said angle α is from about 40 to about 80.

15 54. An apparatus for magnetization as set forth in claim 53, wherein said angle α is from about 50 to about 70.

20

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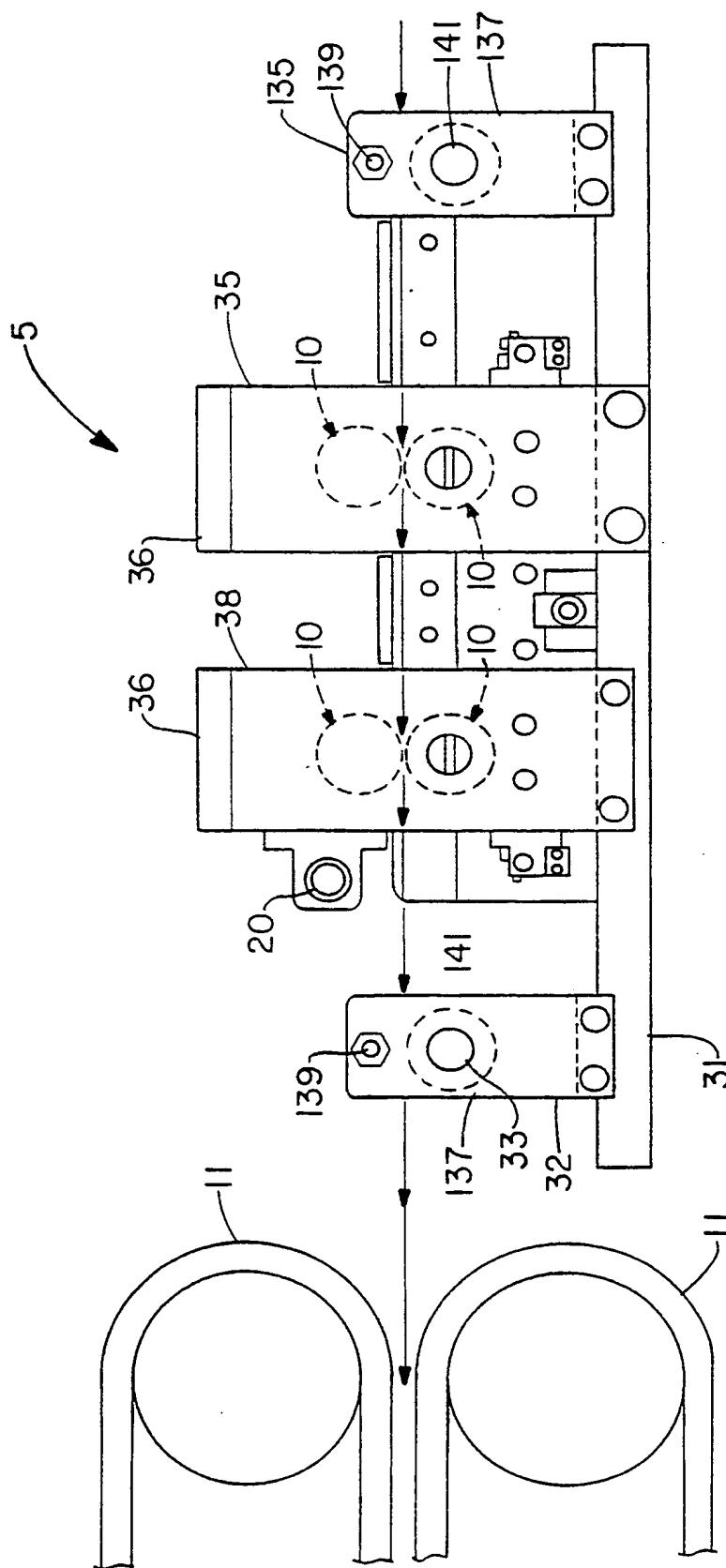


FIG. -1

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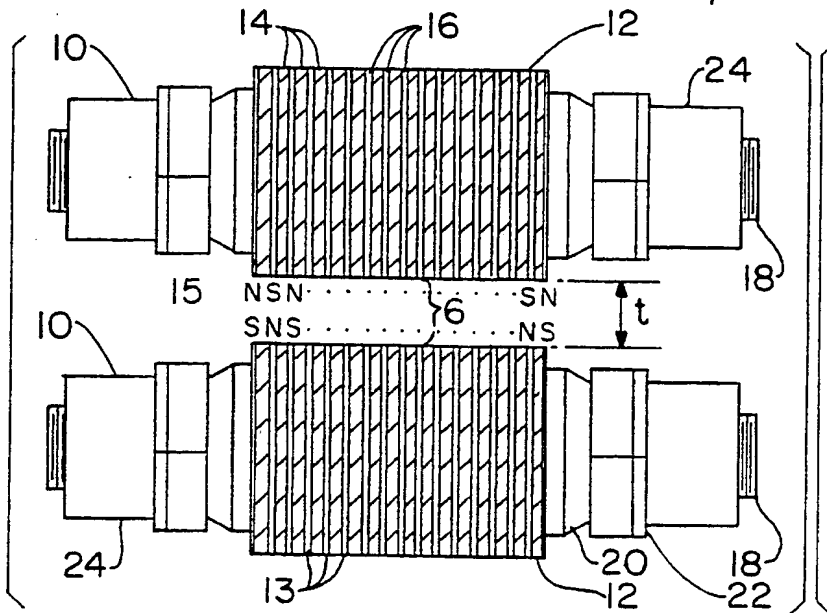


FIG.-3

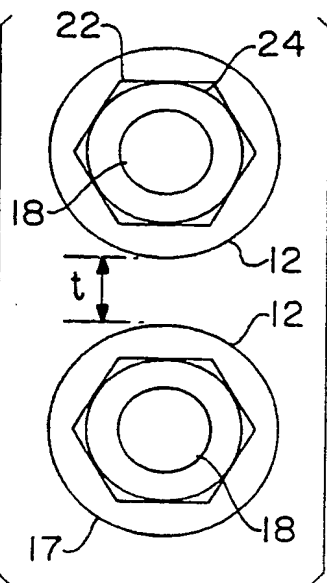


FIG.-4

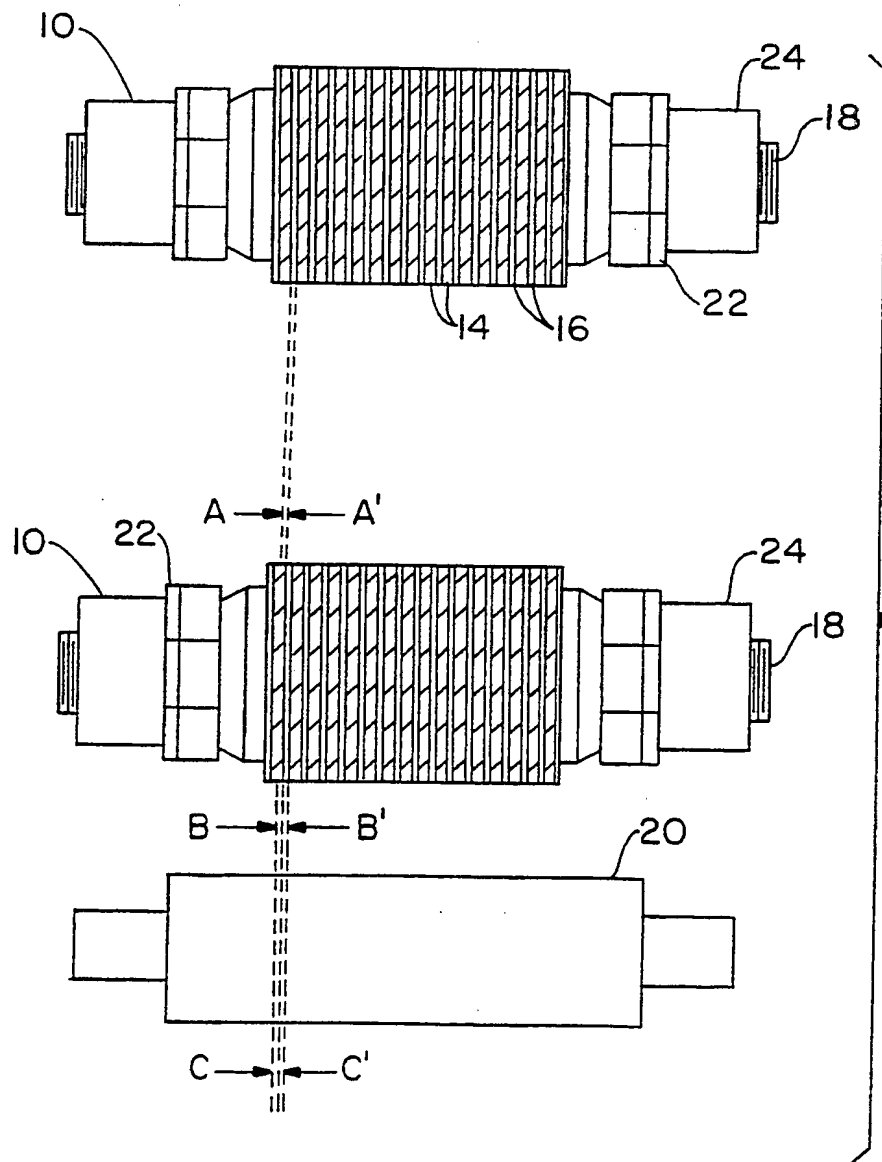
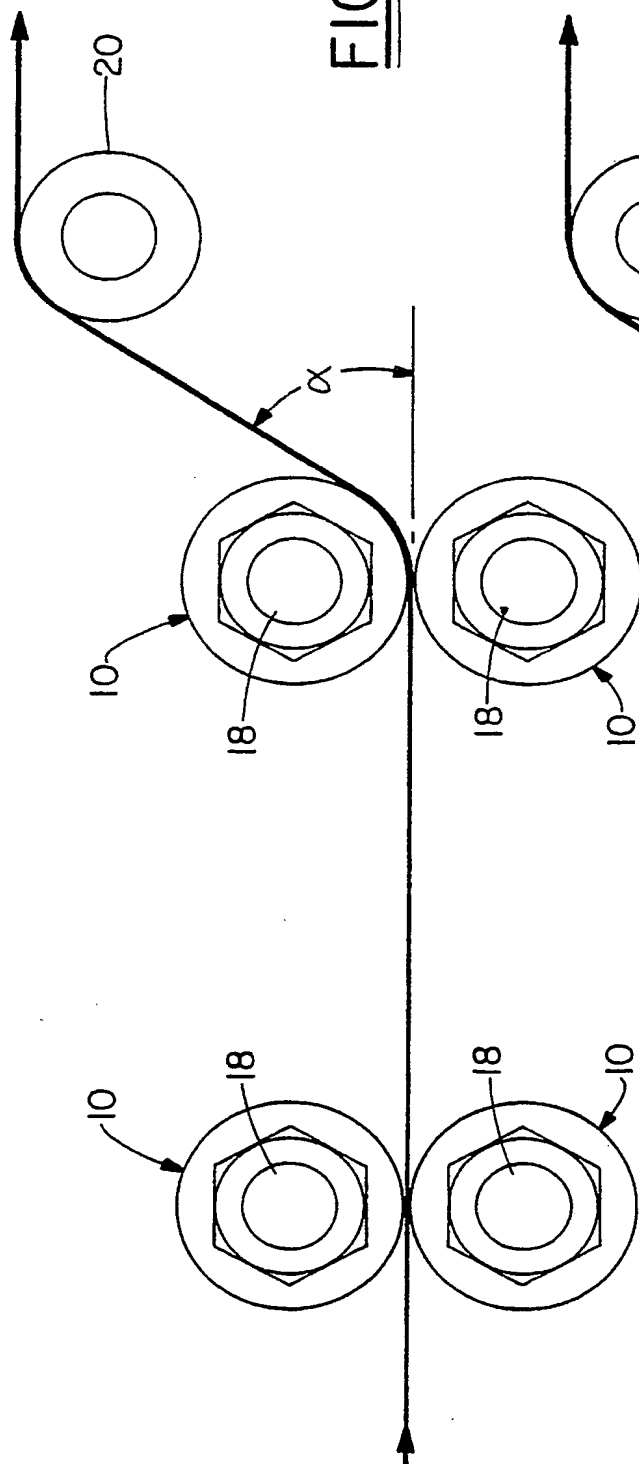
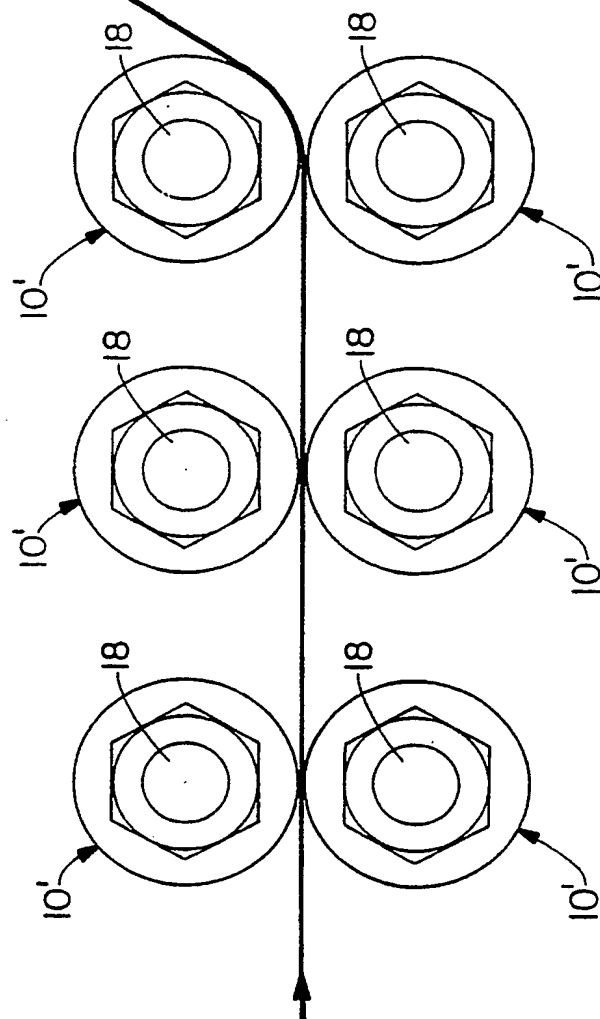


FIG.-5

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FIG.-6FIG.-8

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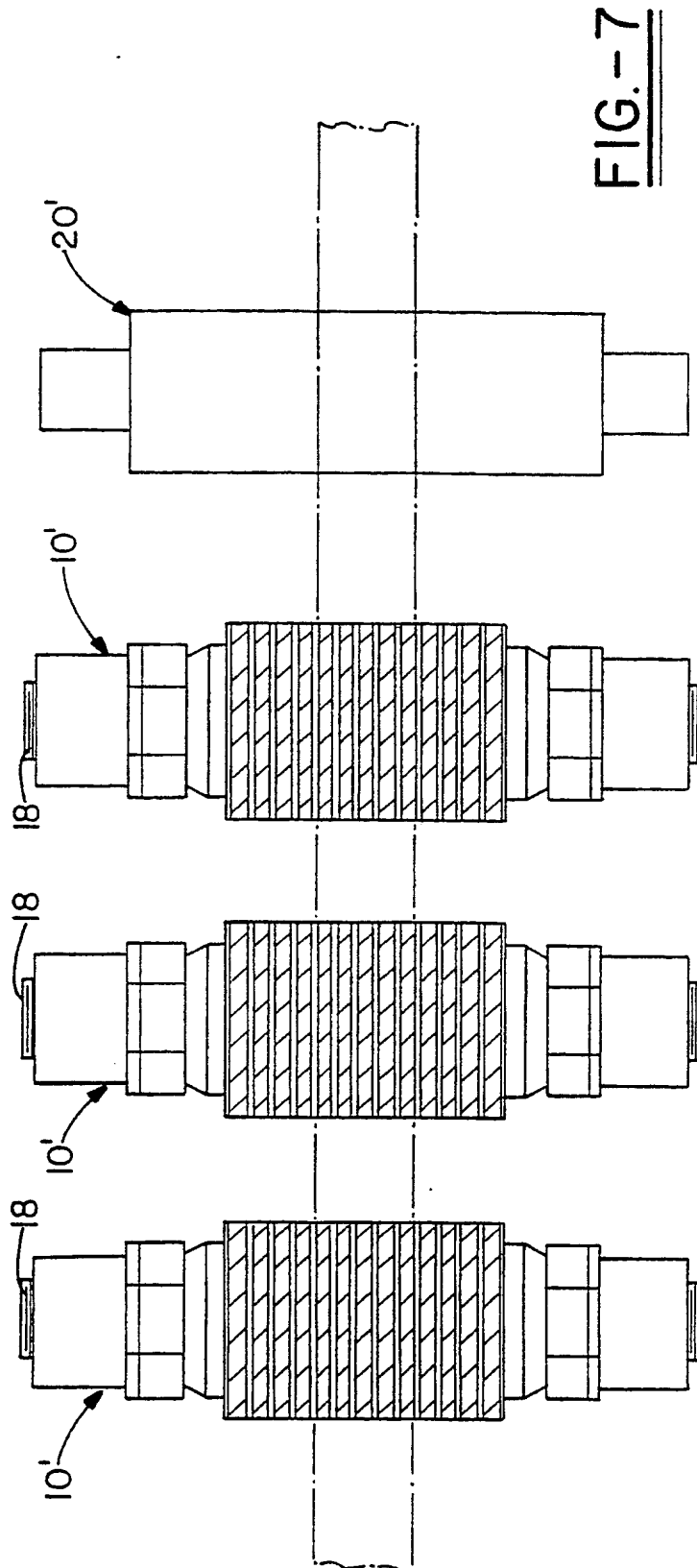


FIG.-7

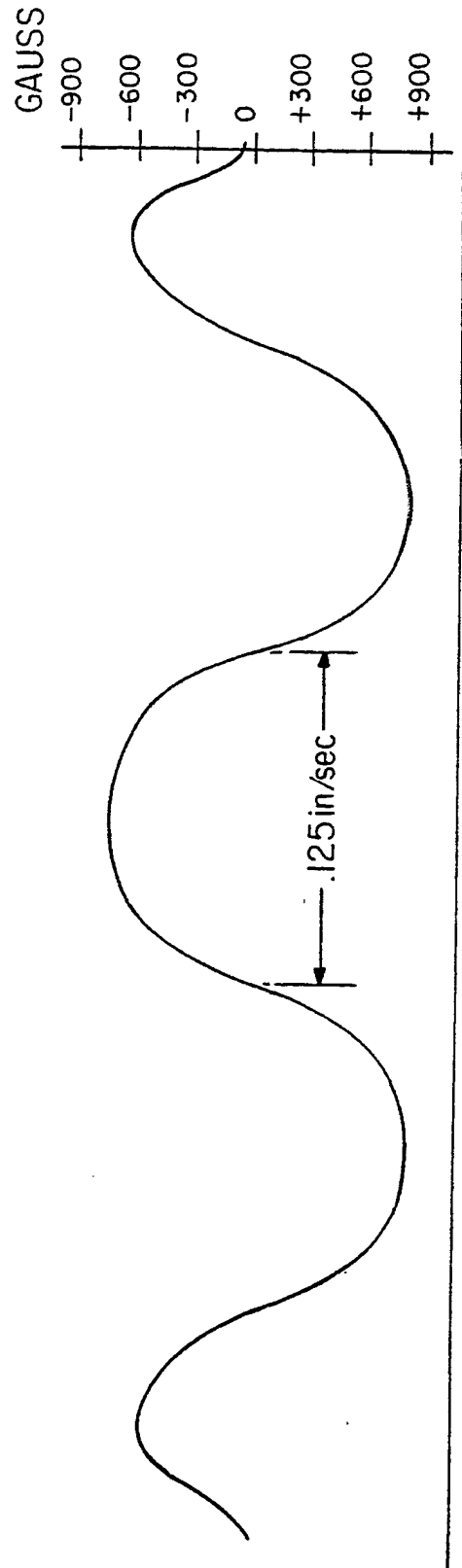


FIG.-14

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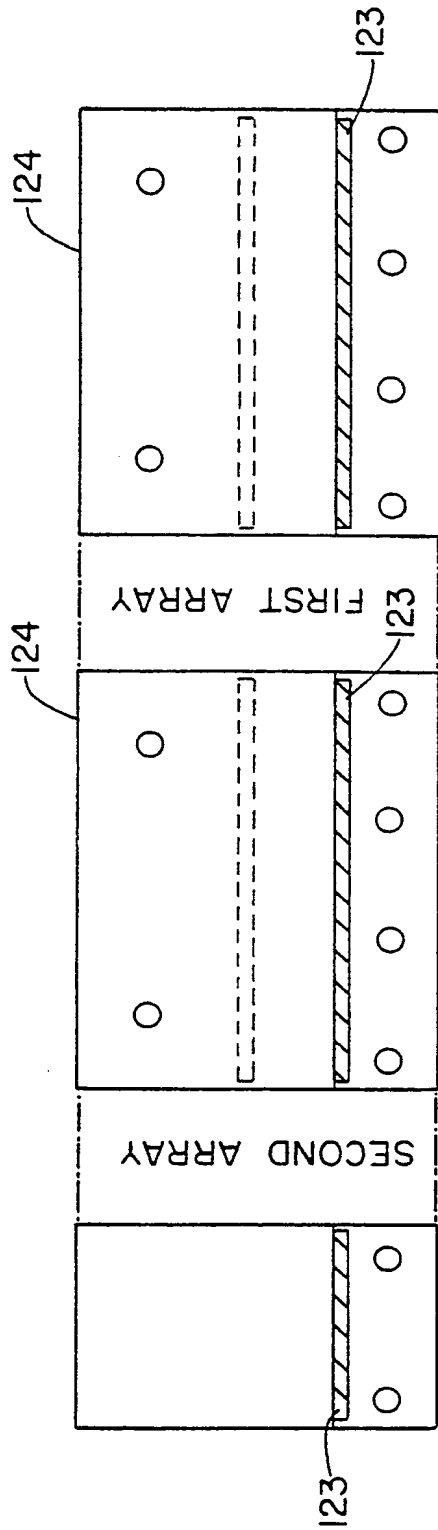


FIG. -10

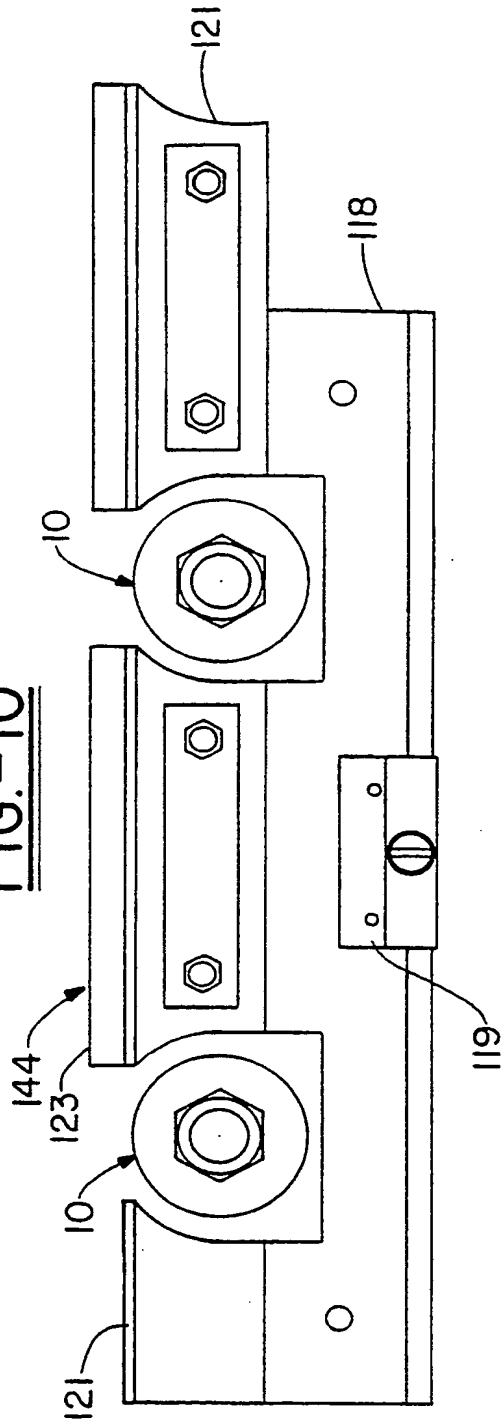


FIG. -11

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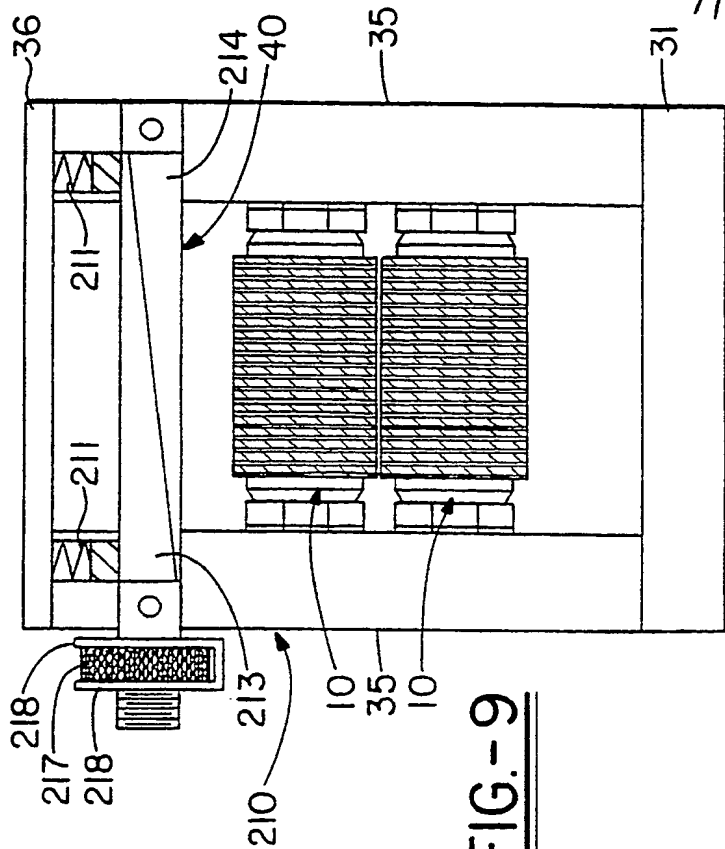


FIG. 9

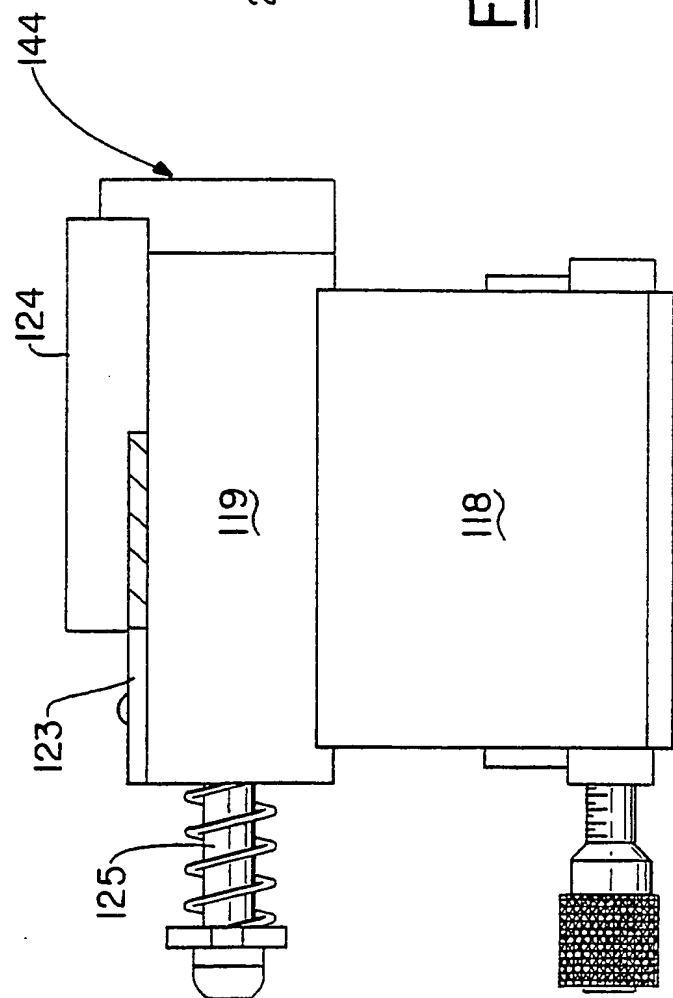


FIG. 12

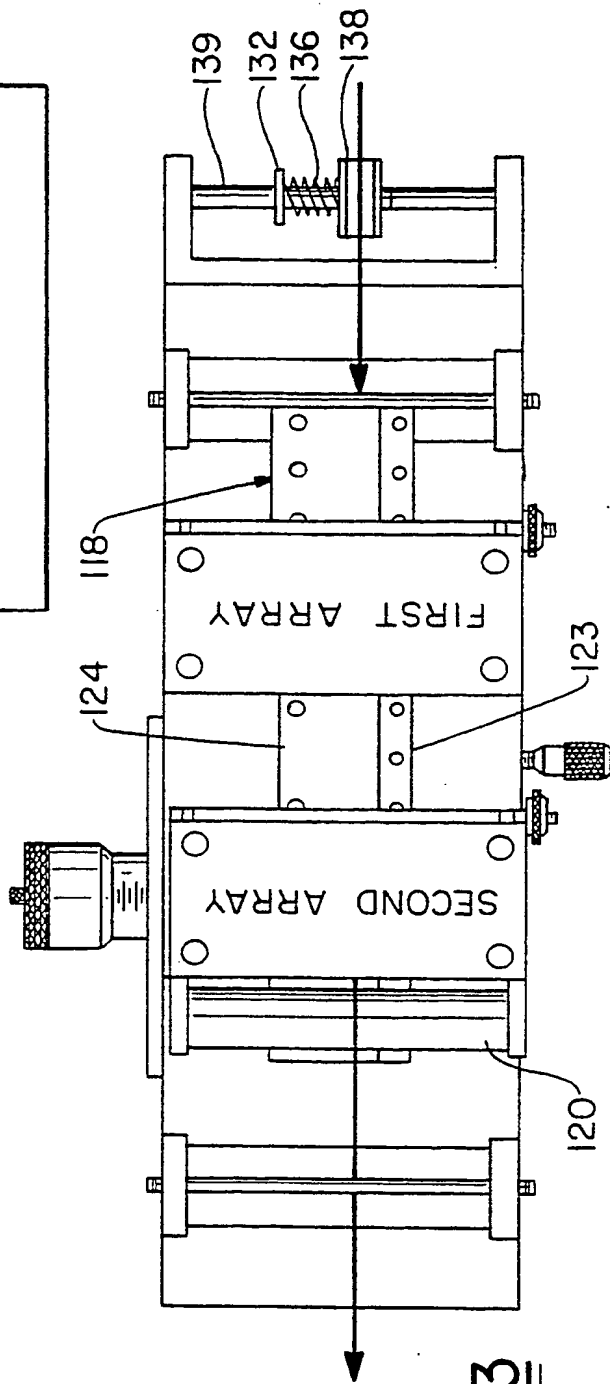
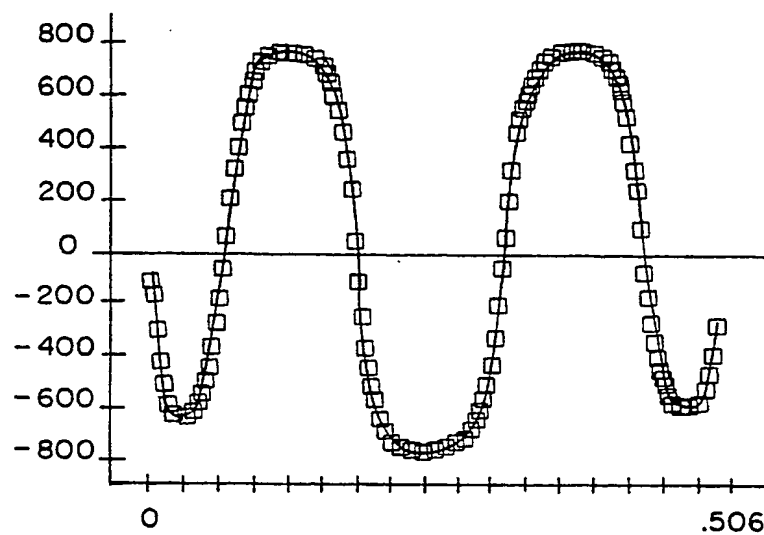


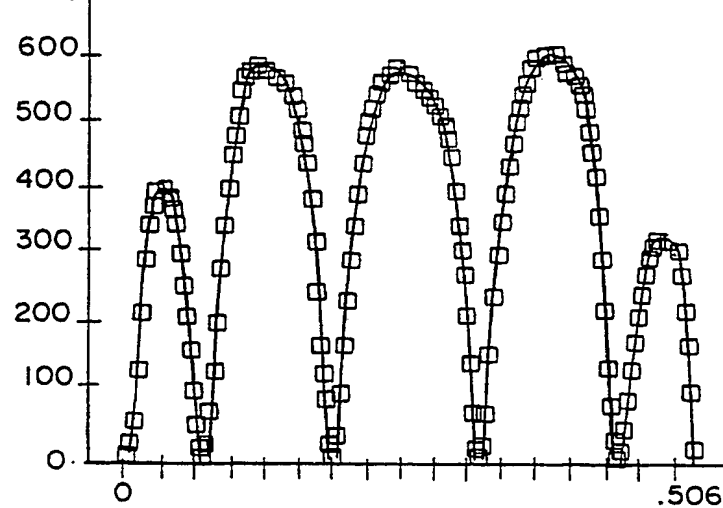
FIG. 13

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GAUSS



DISTANCE (in.)

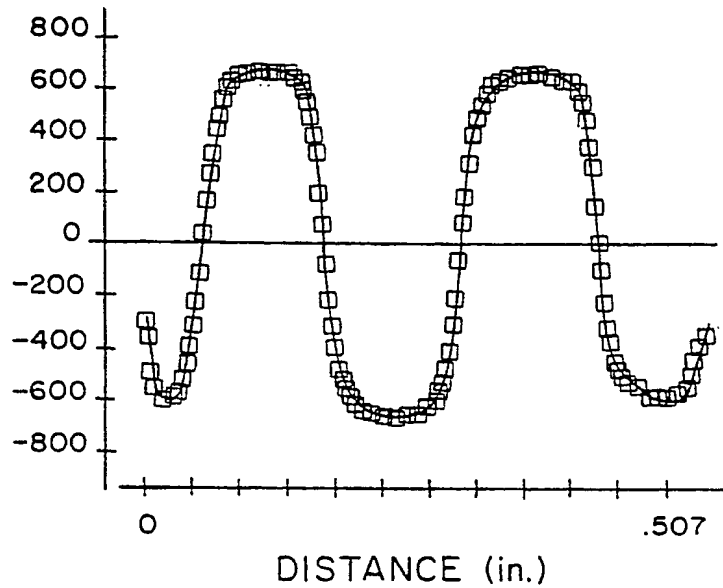
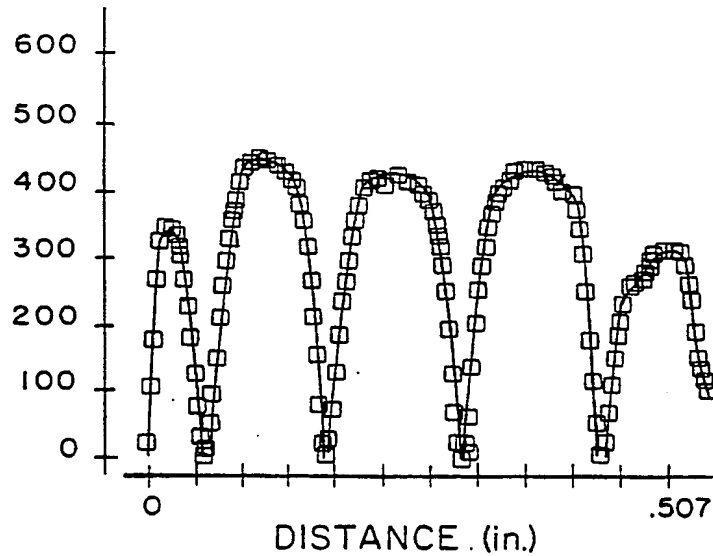
FIG.-15GAUSS (10^{-3})

DISTANCE (in.)

FIG.-16

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GAUSS

FIG.-17GAUSS (10^{-3})FIG.-18

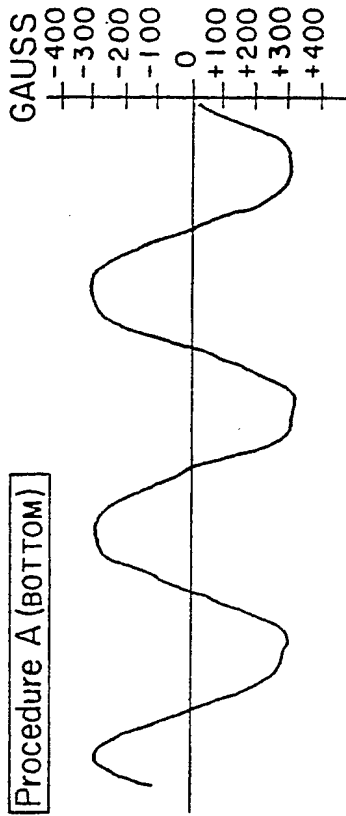


FIG.-19A'

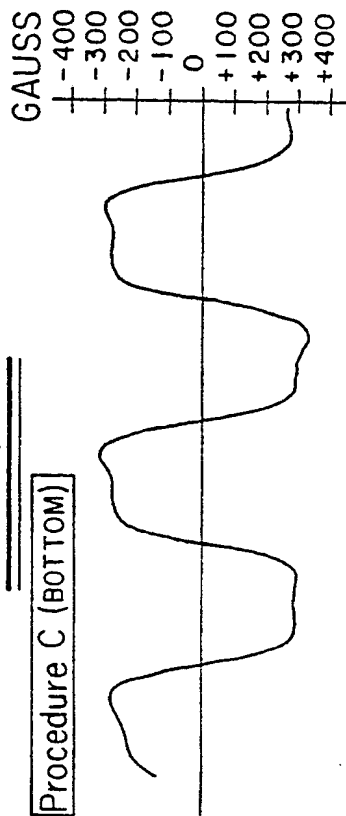


FIG.-19B'

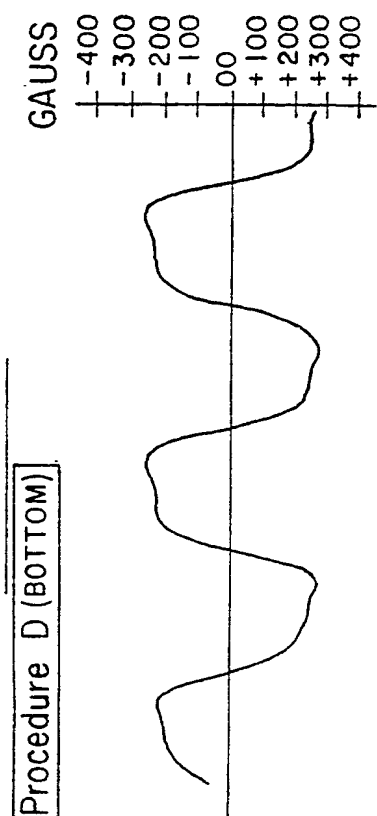


FIG.-19C'

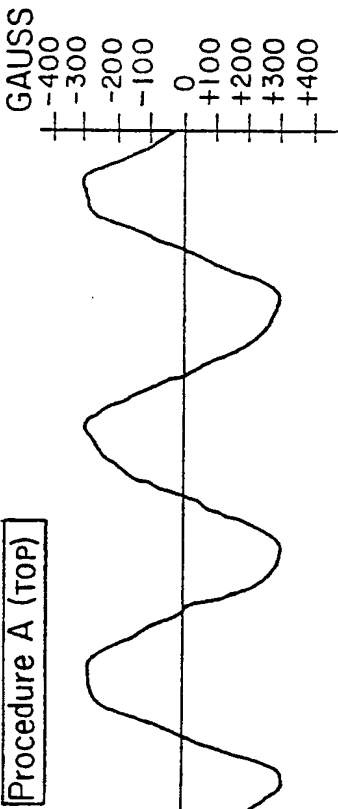


FIG.-19A

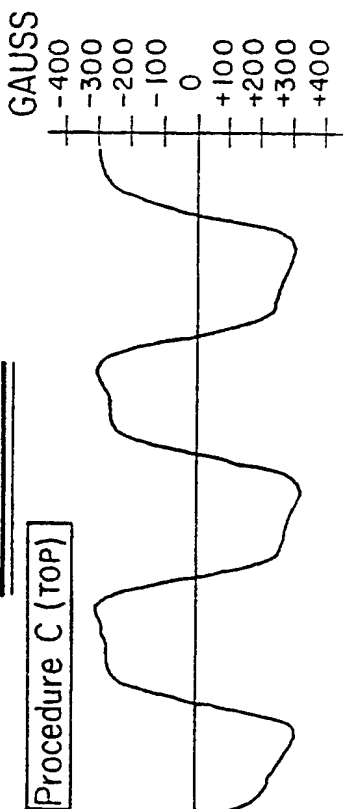


FIG.-19B

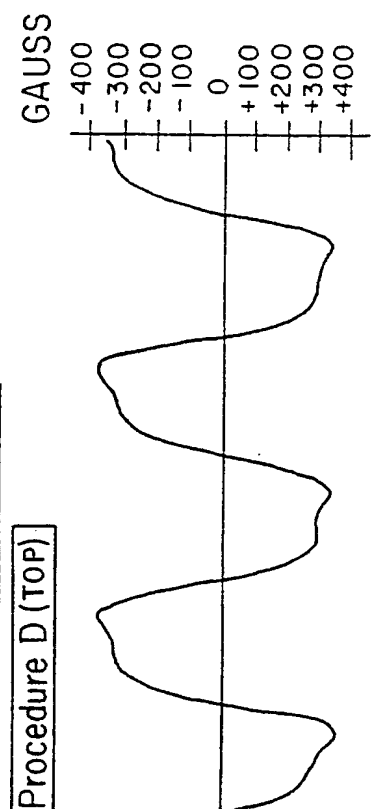


FIG.-19C

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INTERNATIONAL SEARCH REPORT

International application No.

PCT/US93/03446

A. CLASSIFICATION OF SUBJECT MATTER

IPC(5) : Please See Extra Sheet.

US CL : Please See Extra Sheet.

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

U.S. : 335/284, 302, 303, 306

252/62.51, 62.53, 62.54, 62.56

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

APS

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X -- Y	US, A, 4379276 (BOUCHARA, ET.AL) 05 APRIL 1983, SEE FIGURE 3.	39,45,50 ----- 46-48

☐ Further documents are listed in the continuation of Box C.☐ See patent family annex.

* Special categories of cited documents:

A document defining the general state of the art which is not considered to be part of particular relevance

E earlier document published on or after the international filing date

L document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)

O document referring to an oral disclosure, use, exhibition or other means

P document published prior to the international filing date but later than the priority date claimed

T

later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention

X

document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone

Y

document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art

&

document member of the same patent family

Date of the actual completion of the international search

24 JUNE 1993

Date of mailing of the international search report

28 JUL 1993

Name and mailing address of the ISA/US
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Washington, D.C. 20231

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Form PCT/ISA/210 (second sheet)(July 1992)*

INTERNATIONAL SEARCH REPORT

International application No.
PCT/US93/03446

A. CLASSIFICATION OF SUBJECT MATTER:
IPC (5):

H01F 01/113, 07/02, 13/00

A. CLASSIFICATION OF SUBJECT MATTER:
US CL :

335/284, 302, 303, 306
252/62.51

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